

Application/Control No.	Applicant(s)/Patent under Reexamination
10/773,401	EXIR, JULIA
Examiner	Art Unit
Binh X. Tran	1765

	SEARCHED				
Class	Subclass	Date	Examiner		
216	2	7/17/2006	ВТ		
216	56	7/17/2006	ВТ		
216	7	7/17/2006	ВТ		
117	70	7/17/2006	ВТ		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	1-				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Search inventor's name and keywords using USPAT, USPG-PUB, JPO, EPO, DERWENT databases	7/17/2006	вт		